

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/750,156	PARK ET AL.
	Examiner	Art Unit
	Tan T. Nguyen	2827

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
365	51	7/22/2005	TNT
365	63	7/22/2005	TNT
365	230.03	7/22/2005	TNT
365/230.05		7/22/2005	TNT